AMMP-6222

7 to 21 GHz GaAs High Linearity LNA in SMT Package



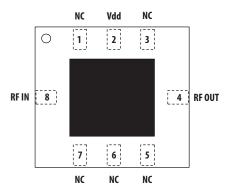
Data Sheet



Description

Avago Technologies' AMMP-6222 is an easy-to-use broadband, high gain, high linearity Low Noise Amplifier in a surface mount package. The wide band and unconditionally stable performance makes this MMIC ideal as a primary or sub-sequential low noise block or a transmitter or LO driver. The MMIC has 3 gain stages and a selectable pin to switch between low and high current, corresponding with low and high output power and linearity. In the high current, high output power state, it requires a 4V, 120mA supply. In the low current, low output power state, the supply is reduced to 4V, 95mA. Since this MMIC covers several bands, it can reduce part inventory and increase volume purchase options The MMIC is fabricated using PHEMT technology. The surface mount package eliminates the need of "chip & wire" assembly for lower cost. This MMIC is fully SMT compatible with backside grounding and I/Os.

Package Diagram



Note:

1. This MMIC uses depletion mode pHEMT devices.

RoHS-Exemption



Please refer to hazardous substances table on page 11.

Features

- Surface Mount Package, 5.0 x 5.0 x 1.25 mm
- Single Positive Bias Pin
- Selectable Output Power / Linearity
- No Negative Gate Bias

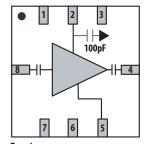
Specifications (Vdd = 4.0V, Idd = 120mA)

- RF Frequencies: 7 21 GHz
- High Output IP3: 29dBm
- High Small-Signal Gain: 24dB
- Typical Noise Figure: 2.3dB
- Input, Output Match: -10dB

Applications

- Microwave Radio systems
- Satellite VSAT, DBS Up/Down Link
- LMDS & Pt-Pt mmW Long Haul
- Broadband Wireless Access (including 802.16 and 802.20 WiMax)
- WLL and MMDS loops

Functional Block Diagram



Vdd
RFout
Current Sel
RFin

Top view Package base: GND



Attention: Observe precautions for handling electrostatic sensitive devices. ESD Machine Model (Class A) = 60V ESD Human Body Model (Class 0) = 150V Refer to Avago Application Note A004R: Electrostatic Discharge, Damage and Control.

Note: MSL Rating = Level 2A

Electrical Specifications

- 1. Small/Large -signal data measured in a fully de-embedded test fixture form TA = 25°C.
- 2. Pre-assembly into package performance verified 100% on-wafer per AMMC-6220 published specifications.
- 3. This final package part performance is verified by a functional test correlated to actual performance at one or more frequencies.
- 4. Specifications are derived from measurements in a $50\,\Omega$ test environment. Aspects of the amplifier performance may be improved over a more narrow bandwidth by application of additional conjugate, linearity, or low noise (Γ opt) matching.
- 5. All tested parameters guaranteed with measurement accuracy +/-1dB/dBm/dBc

Table 1. RF Electrical Characteristics

	High Out	put Power Con	figuration	Lower Output Power Configuration				
Parameter	Min	Typical	Max	Min	Typical	Max	Unit	Comment
Drain Current, Idd		120			95		dB	
Small Signal Gain, Gain	19	24			23		GHz	
Noise Figure into 50 Ω , NF		2.3	3.5		2.3		dB	Tested at 29.25 and 30 GHz
Output Power at 1dB Gain Compression, P1dB		15.5			14		dBm	
Output Power at 3dB Gain Compression, P3dB		17.5			16		dBm	
Output Third Order Inter- cept Point, OIP3		29			27		dBm	
Isolation, Iso		-45			-45		dB	
Input Return Loss, Rlin		-10			-10		dB	
Output Return Loss, RLout		-10			-10		dB	

Table 2. Recommended Operating Range

- 1. Ambient operational temperature TA = 25°C unless otherwise noted.
- 2. Channel-to-backside Thermal Resistance (Tchannel (Tc) = 34° C) as measured using infrared microscopy. Thermal Resistance at backside temperature (Tb) = 25° C calculated from measured data.

Description	Min.	Typical	Max.	Unit	Comments
Drain Supply Current, Id		200	250	mA	Vd = 4.5 V, Under any RF power drive and temperature
Drain Supply Voltage, Vd	3.5	4.5	5	V	

Table 3. Thermal Properties

Parameter	Test Conditions	Value
Thermal Resistance, θch-b	Channel-to-backside Thermal Resistance Tchannel(Tc)=34°C Thermal Resistance at backside temperature Tb=25°C	θ ch-b = 31.47 °C/W

Absolute Minimum and Maximum Ratings

Table 4. Minimum and Maximum Ratings

Description	Pin	Min.	Max.	Unit	Comments
Drain to Ground Supply Voltage	Vdd		5.5	V	
Drain Current	Idd		170	mA	
RF CW Input Power	Pin		10	dBm	CW
Channel Temperature			+150	°C	
Storage Temperature		-65	+150	°C	
Maximum Assembly Temperature			260	°C	20 second maximum

 $Notes: 1. \ Operation\ in\ excess\ of\ any\ one\ of\ these\ conditions\ may\ result\ in\ permanent\ damage\ to\ this\ device.$

AMMP-6222 Typical Performance for High Current, High Output Power Configuration [1], [2]

 $(T_A = 25^{\circ}C, Vdd=4V, Idd=120mA, Zin = Zout = 50 \Omega unless noted)$

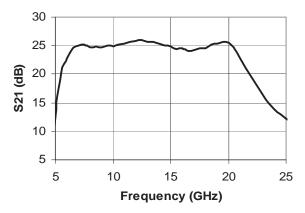


Figure 1a. Small-signal Gain

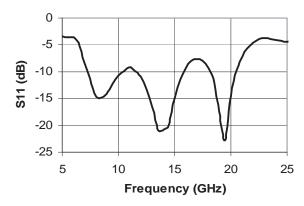


Figure 3a. Input Return Loss

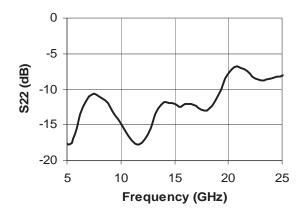


Figure 5a. Output Return Loss

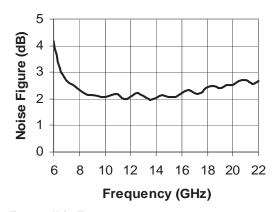


Figure 2a. Noise Figure

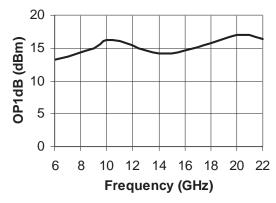


Figure 4a. Output P-1dB

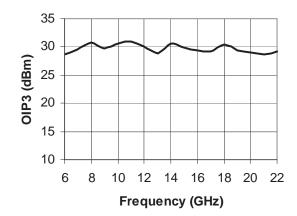


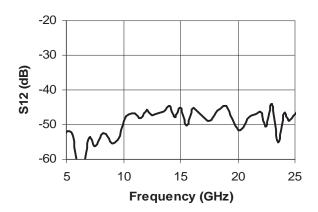
Figure 6a. Output IP3

Note:

- 1. S-parameters are measured with R&D Eval Board as shown in Figure 21. Board and connector effects are included in the data.
- 2. Noise Figure is measured with R&D Eval board as shown in Figure 21, and with a 3-dB pad at input. Board and connector losses are already deembeded from the data.

AMMP-6222 Typical Performance for High Current, High Output Power Configuration (Cont)

 $(T_A = 25$ °C, Vdd=4V, Idd=120mA, Zin = Zout = 50 Ω unless noted)



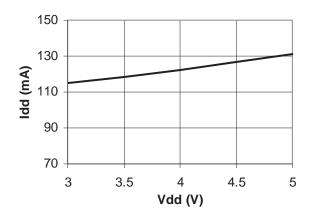


Figure 7a. Isolation

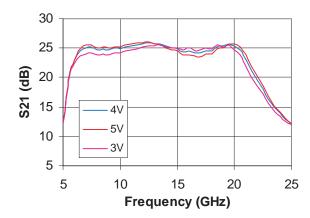


Figure 8a. Idd over Vdd

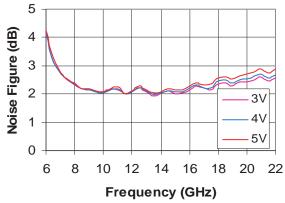


Figure 9a. Small-signal Gain Over Vdd

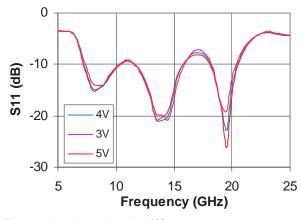


Figure 10a. Noise Figure Over Vdd

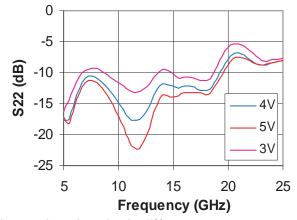
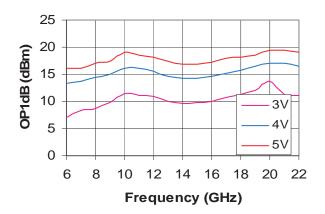


Figure 11a. Input Return Loss Over Vdd

Figure 12a. Output Return Loss Over Vdd

AMMP-6222 Typical Performance for High Current, High Output Power Configuration (Cont)

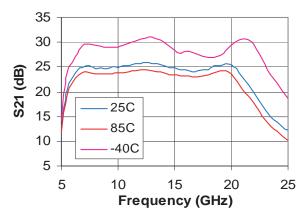
(TA = 25°C, Vdd=4V, Idd=120mA, Zin = Zout = 50Ω unless noted)



35 30 25 OIP3 (dBm) 20 15 3V 10 4V 5 5V 0 8 10 12 14 16 18 20 22 6 Frequency (GHz)

Figure 13a. Output P1dB over Vdd

Figure 14a. Output IP3 over Vdd



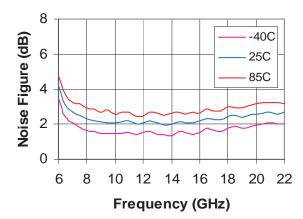
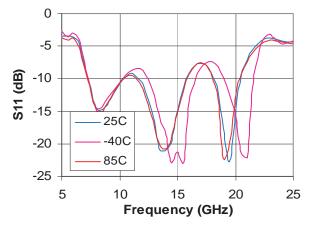


Figure 15a. Small-signal Gain Over Temp

Figure 16a. Noise Figure Over Temp



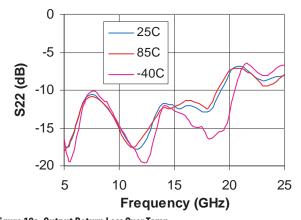
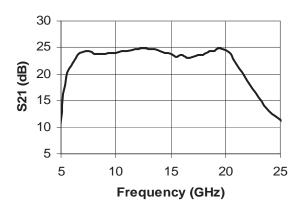


Figure 17a. Input Return Loss Over Temp

Figure 18a. Output Return Loss Over Temp

AMMP-6222 Typical Performance for Low Current, Low Output Power Configuration [1], [2]

 $(T_A = 25$ °C, Vdd=4V, Idd=95mA, Zin = Zout = 50 Ω unless noted)



5 89 4 3 2 6 8 10 12 14 16 18 20 22 Frequency (GHz)

Figure 1b. Small-signal Gain

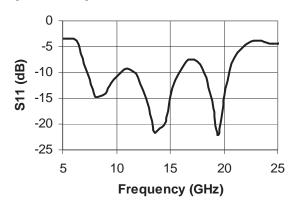


Figure 2b. Noise Figure

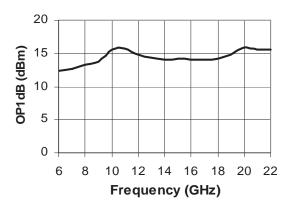


Figure 3b. Input Return Loss

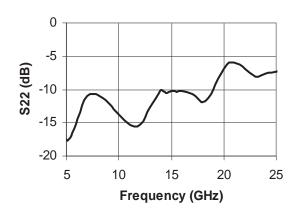


Figure 4b. Output P-1dB

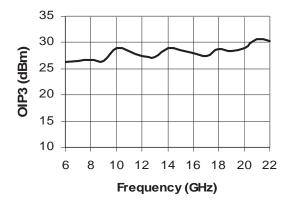


Figure 5b. Output Return Loss

Figure 6b. Output IP3

Note:

- 1. S-parameters are measured with R&D Eval Board as shown in Figure 21. Board and connector effects are included in the data.
- 2. Noise Figure is measured with R&D Eval board as shown in Figure 21, and with a 3-dB pad at input. Board and connector losses are already deembeded from the data

AMMP-6222 Typical Performance for Low Current, Low Output Power Configuration (Cont)

 $(T_A = 25$ °C, Vdd=4V, Idd=95mA, Zin = Zout = 50 Ω unless noted)

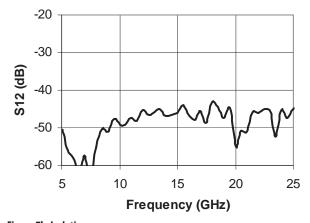


Figure 7b. Isolation

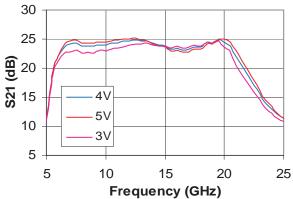


Figure 9b. Small-signal Gain Over Vdd

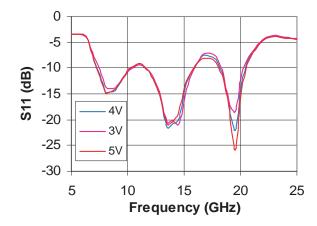


Figure 11b. Input Return Loss Over Vdd

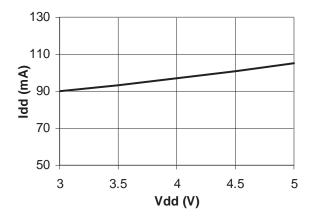


Figure 8b. Idd over Vdd

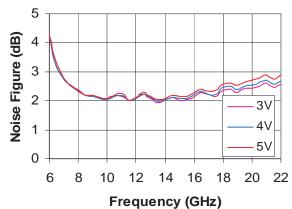


Figure 10b. Noise Figure Over Vdd

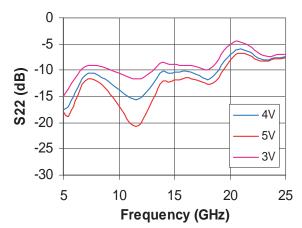


Figure 12b. Output Return Loss Over Vdd

AMMP-6222 Typical Performance for Low Current, Low Output Power Configuration (Cont)

 $(T_A = 25$ °C, Vdd=4V, Idd=95mA, Zin = Zout = 50 Ω unless noted)

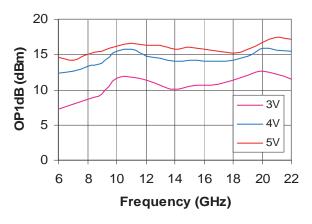


Figure 13b. Output P1dB over Vdd

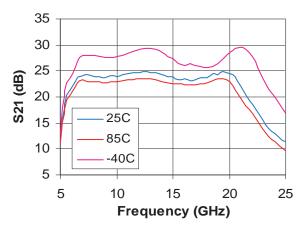


Figure 15b. Small-signal Gain Over Temp

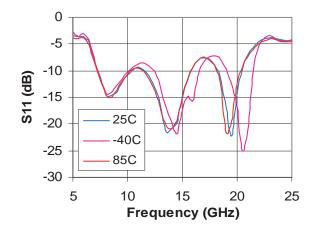


Figure 17b. Input Return Loss Over Temp

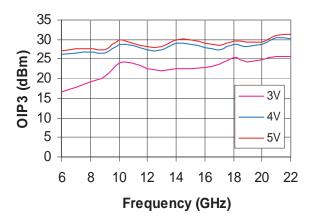


Figure 14b. Output IP3 over Vdd

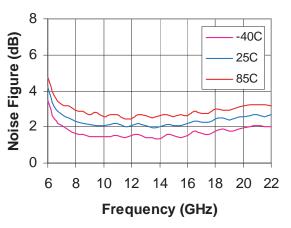


Figure 16b. Noise Figure Over Temp

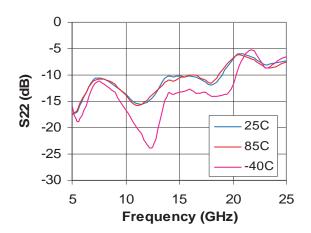


Figure 18b. Output Return Loss Over Temp

AMMP-6222 Application and Usage

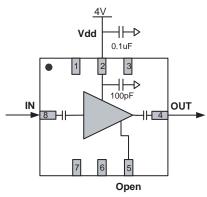


Figure 19. Low Current, Low Output Power State

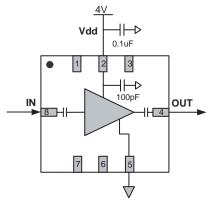


Figure 20. High Current, High Output Power State

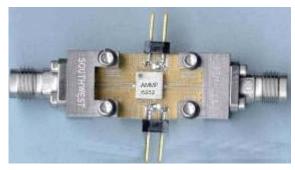


Figure 21. Evaluation/Test Board (available to qualified customer request)

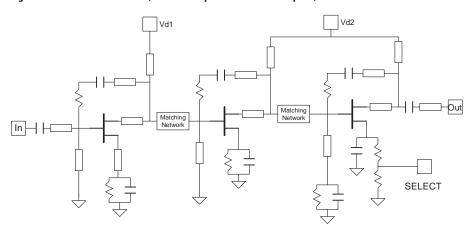


Figure 22. Simplified High Linearity LNA Schematic

Biasing and Operation

The AMMP-6222 is normally biased with a positive drain supply connected to the VDD pin through bypass capacitor as shown in Figures 19 and 20. The recommended drain supply voltage for general usage is 4V and the corresponding drain current is approximately 120mA. It is important to have 0.1uF bypass capacitor and the capacitor should be placed as close to the component as possible. Aspects of the amplifier performance may be improved over a narrower bandwidth by application of additional conjugate, linearity, or low noise (Topt) matching.

For receiver front end low noise applications where high power and linearity are not often required, the AMMP-6222 can be set in low current state when pin # 5 is open as shown in Figure 19. In this configuration, the bias current is approximately 90mA, 95mA and 100mA for 3V, 4V and 5V respectively.

In applications where high output power and linearity are often required such as LO or transmitter drivers, the AMMP-6222 can be selected to operate at its highest output power by grounding pin # 5 as shown in Figure 20. At 5V, the amplifier can provide Psat of ~ 20dBm. The bias current in this configuration is 115mA, 120mA and 125mA for 3V, 4V and 5V respectively.

Refer the Absolute Maximum Ratings table for allowed DC and thermal conditions.

Typical Scattering Parameters

Please refer to http://www.avagotech.com for typical scattering parameters data.

Package Dimension, PCB Layout and Tape and Reel information

Please refer to Avago Technologies Application Note 5520, AMxP-xxxx production Assembly Process (Land Pattern A).

Ordering Information

Part Number	Devices Per Container	Container
AMMP-6222-BLKG	10	Antistatic bag
AMMP-6222-TR1G	100	7" Reel
AMMP-6222-TR2G	500	7" Reel



Names and Contents of the Toxic and Hazardous Substances or Elements in the Products

产品中有毒有害物质或元素的名称及含量

Part Name	Toxic and Hazardous Substances or Elements 有毒有害物质或元素								
	LeadMercuryCadmiumHexavalentPolybrominatedPolybrominated(Pb) 铅(Hg) 汞(Cd) 镉(Cr(VI)) 六价biphenyl (PBB)多diphenylether (PBDE)								
部件名称	(Pb)	(Hg)	(Cd)	铬(Cr(VI))	溴联苯(PBB)	多溴二苯醚(PBDE)			
100pF capacitor	×	0	0	0	0	0			

- O: indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006.
- x: indicates that the content of the toxic and hazardous substance in at least one homogeneous material of the part exceeds the concentration limit requirement as described in SJ/T 11363-2006.

(The enterprise may further explain the technical reasons for the "x" indicated portion in the table in accordance with the actual situations.)

- O:表示该有毒有害物质在该部件所有均质材料中的含量均在 SJ/T 11363-2006 标准规定的限量要求以下。
- x:表示该有毒有害物质至少在该部件的某一均质材料中的含量超出 SJ/T 11363-2006 标准规定的限量要求。(企业可在此处,根据实际情况对上表中打"x"的技术原因进行进一步说明。)

Note: EU RoHS compliant under exemption clause of "lead in electronic ceramic parts (e.g. piezoelectronic devices)"

